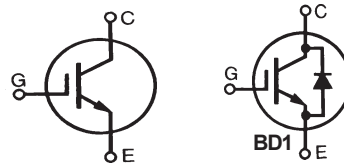


## High Voltage IGBT with Diode

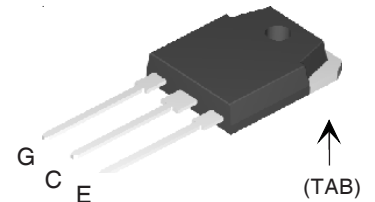
**IXGQ 20N120B**  
**IXGQ 20N120BD1**



$V_{CES} = 1200 \text{ V}$   
 $I_{C25} = 40 \text{ A}$   
 $V_{CE(sat)} = 3.4 \text{ V}$   
 $t_{fi(typ)} = 160 \text{ ns}$

| Symbol  | Test Conditions   | Maximum Ratings                  |                  |
|---|---|----------------------------------|------------------|
| $V_{CES}$   | $T_J = 25^\circ\text{C to } 150^\circ\text{C}$  | 1200                             | V                |
| $V_{CGR}$   | $T_J = 25^\circ\text{C to } 150^\circ\text{C}; R_{GE} = 1 \text{ M}\Omega$                  | 1200                             | V                |
| $V_{GES}$   | Continuous  | $\pm 20$                         | V                |
| $V_{GEM}$   | Transient   | $\pm 30$                         | V                |
| $I_{C25}$   | $T_C = 25^\circ\text{C}$  | 40                               | A                |
| $I_{C110}$  | $T_C = 110^\circ\text{C}$   | 20                               | A                |
| $I_{CM}$  | $T_C = 25^\circ\text{C}, 1 \text{ ms}$  | 100                              | A                |
| <b>SSOA (RBSOA)</b>   | $V_{GE} = 15 \text{ V}, T_J = 125^\circ\text{C}, R_G = 10 \Omega$<br>Clamped inductive load | $I_{CM} = 40$<br>@ $0.8 V_{CES}$ | A                |
| $P_C$   | $T_C = 25^\circ\text{C}$  | 190                              | W                |
| $T_J$   |   | -55 ... +150                     | $^\circ\text{C}$ |
| $T_{JM}$  |   | 150                              | $^\circ\text{C}$ |
| $T_{stg}$   |   | -55 ... +150                     | $^\circ\text{C}$ |
| $M_d$   | Mounting torque   | 1.13/10 Nm/lb.in.                |                  |
| Maximum lead temperature for soldering<br>1.6 mm (0.062 in.) from case for 10 s |   | 300                              | $^\circ\text{C}$ |
| <b>Weight</b>   |   | 6                                | g                |

### TO-3P (IXGQ)



G = Gate  
E = Emitter  
C = Collector  
TAB = Collector

### Features

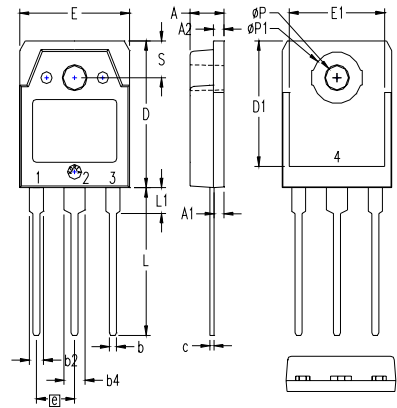
- International standard package
- IGBT and anti-parallel FRED for resonant power supplies
  - Induction heating
  - Rice cookers
- MOS Gate turn-on
  - drive simplicity
- Fast Recovery Exipitaxial Diode (FRED)
  - soft recovery with low  $I_{RM}$

### Advantages

- Saves space (two devices in one package)
- Easy to mount with 1 screw (isolated mounting screw hole)
- Reduces assembly time and cost

| Symbol        | Test Conditions                                       | Characteristic Values<br>( $T_J = 25^\circ\text{C}$ , unless otherwise specified) |                           |  |
|---------------|---|---|---------------------------|--|
|               |   | min.  | typ.                      | max.   |
| $V_{GE(th)}$  | $I_C = 250 \mu\text{A}, V_{CE} = V_{GE}$              | 2.5   |                           | 5.0 V  |
| $I_{CES}$     | $V_{CE} = V_{CES}$<br>$V_{GE} = 0 \text{ V}$          |   |                           | 20N120B: 25 $\mu\text{A}$<br>20N120BD1: 50 $\mu\text{A}$ |
| $I_{GES}$     | $V_{CE} = 0 \text{ V}, V_{GE} = \pm 20 \text{ V}$     |   |                           | $\pm 100 \text{ nA}$                                     |
| $V_{CE(sat)}$ | $I_C = 20 \text{ A}, V_{GE} = 15 \text{ V}$<br>Note 2 |   | $T_J = 125^\circ\text{C}$ | 2.9 V<br>2.8 V   |

| Symbol                    | Test Conditions  | Characteristic Values                               |      |          |
|---------------------------|--|---|------|----------|
|                           |  | (T <sub>J</sub> = 25°C, unless otherwise specified) |      |          |
|                           |  | min.  | typ. | max.     |
| <b>g<sub>fs</sub></b>     | I <sub>C</sub> = 20A; V <sub>CE</sub> = 10 V,<br>Note 2.                             | 12  | 16   | S        |
| <b>C<sub>ies</sub></b>    |  |   | 1700 | pF       |
|                           |  |   | 70   | pF       |
| <b>C<sub>oes</sub></b>    | V <sub>CE</sub> = 25 V, V <sub>GE</sub> = 0 V, f = 1 MHz                             | 20N120B   | 80   | pF       |
| <b>C<sub>res</sub></b>    |  | 20N120BD1   | 23   | pF       |
| <b>Q<sub>g</sub></b>      |  |   | 62   | nC       |
| <b>Q<sub>ge</sub></b>     | I <sub>C</sub> = 20A, V <sub>GE</sub> = 15 V, V <sub>CE</sub> = 0.5 V <sub>CES</sub> |   | 9    | nC       |
| <b>Q<sub>gc</sub></b>     |  |   | 24   | nC       |
| <b>t<sub>d(on)</sub></b>  | <b>Inductive load, T<sub>J</sub> = 25°C</b>  |   | 20   | ns       |
| <b>t<sub>ri</sub></b>     | I <sub>C</sub> = 20 A; V <sub>GE</sub> = 15 V  |   | 14   | ns       |
| <b>t<sub>d(off)</sub></b> | V <sub>CE</sub> = 0.8 V <sub>CES</sub> ; R <sub>G</sub> = R <sub>off</sub> = 10 Ω    |   | 270  | 380 ns   |
| <b>t<sub>fi</sub></b>     | Note 1.  |   | 160  | 320 ns   |
| <b>E<sub>off</sub></b>    |  |   | 2.1  | 3.5 mJ   |
| <b>t<sub>d(on)</sub></b>  | <b>Inductive load, T<sub>J</sub> = 125°C</b>   |   | 25   | ns       |
| <b>t<sub>ri</sub></b>     | I <sub>C</sub> = 20A; V <sub>GE</sub> = 15 V   |   | 18   | ns       |
| <b>E<sub>on</sub></b>     | V <sub>CE</sub> = 0.8 V <sub>CES</sub> ; R <sub>G</sub> = R <sub>off</sub> = 10 Ω    |   | 1.4  | mJ       |
| <b>t<sub>d(off)</sub></b> | Note 1   |   | 270  | ns       |
| <b>t<sub>fi</sub></b>     |  |   | 360  | ns       |
| <b>E<sub>off</sub></b>    |  |   | 4.5  | mJ       |
| <b>R<sub>thJC</sub></b>   |  |   |      | 0.65 K/W |
| <b>R<sub>thCK</sub></b>   | (TO-247)   |   | 0.25 | K/W      |

**TO-3P (IXGQ) Outline**


- 1 - GATE
- 2 - DRAIN (COLLECTOR)
- 3 - SOURCE (EMITTER)
- 4 - DRAIN (COLLECTOR)

| SYM | INCHES   |      | MILLIMETERS |       |
|-----|----------|------|-------------|-------|
|     | MIN      | MAX  | MIN         | MAX   |
| A   | .185     | .193 | 4.70        | 4.90  |
| A1  | .051     | .059 | 1.30        | 1.50  |
| A2  | .057     | .065 | 1.45        | 1.65  |
| b   | .035     | .045 | 0.90        | 1.15  |
| b2  | .075     | .087 | 1.90        | 2.20  |
| b4  | .114     | .126 | 2.90        | 3.20  |
| c   | .022     | .031 | 0.55        | 0.80  |
| D   | .780     | .791 | 19.80       | 20.10 |
| D1  | .665     | .677 | 16.90       | 17.20 |
| E   | .610     | .622 | 15.50       | 15.80 |
| E1  | .531     | .539 | 13.50       | 13.70 |
| e   | .215 BSC |      | 5.45 BSC    |       |
| L   | .779     | .795 | 19.80       | 20.20 |
| L1  | .134     | .142 | 3.40        | 3.60  |
| øP  | .126     | .134 | 3.20        | 3.40  |
| øP1 | .272     | .280 | 6.90        | 7.10  |
| S   | .193     | .201 | 4.90        | 5.10  |

All metal area are tin plated.

**Reverse Diode (FRED)**

| Symbol                  | Test Conditions   | Characteristic Values                               |      |         |
|-------------------------|---|---|------|---------|
|                         |   | (T <sub>J</sub> = 25°C, unless otherwise specified) |      |         |
|                         |   | min.  | typ. | max.    |
| <b>I<sub>F</sub></b>    | T <sub>C</sub> = 90°C   |   |      | 10 A    |
| <b>V<sub>F</sub></b>    | I <sub>F</sub> = 10 A, V <sub>GE</sub> = 0 V  |   |      | 3.3 V   |
| <b>I<sub>RM</sub></b>   | I <sub>F</sub> = 10 A; -di <sub>F</sub> /dt = 400 A/μs; V <sub>R</sub> = 600 V                      |   | 14   | A       |
| <b>t<sub>rr</sub></b>   | V <sub>GE</sub> = 0 V; T <sub>J</sub> = 125°C   |   | 120  | ns      |
| <b>t<sub>rr</sub></b>   | I <sub>F</sub> = 1 A; -di <sub>F</sub> /dt = 100 A/μs; V <sub>R</sub> = 30 V, V <sub>GE</sub> = 0 V |   | 40   | ns      |
| <b>R<sub>thJC</sub></b> |   |   |      | 2.5 K/W |

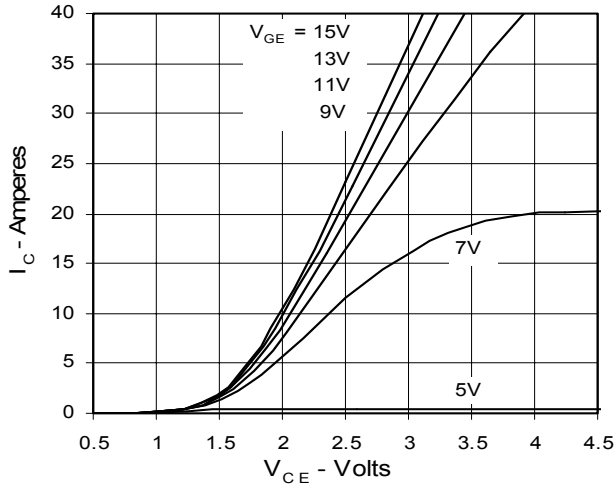
- Notes:
- Switching times may increase for V<sub>CE</sub> (Clamp) > 0.8 • V<sub>CES</sub>, higher T<sub>J</sub> or increased R<sub>G</sub>.
  - Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %

IXYS reserves the right to change limits, test conditions, and dimensions.

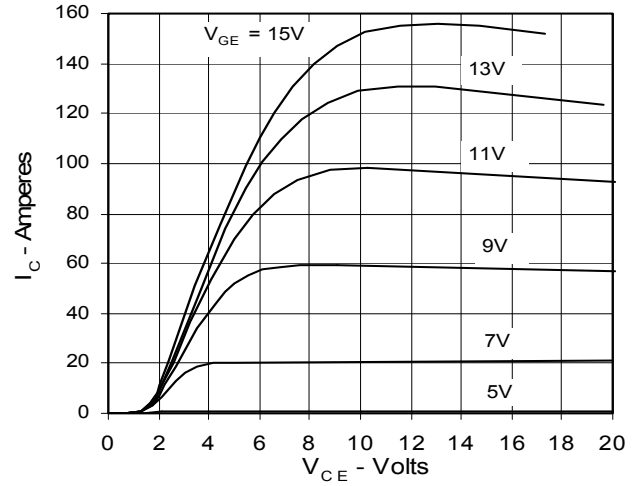
IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents:

4,835,592 4,881,106 5,017,508 5,049,961 5,187,117 5,486,715 6,306,728B1 6,259,123B1 6,306,728B1  
 4,850,072 4,931,844 5,034,796 5,063,307 5,237,481 5,381,025 6,404,065B1 6,162,665 6,534,343

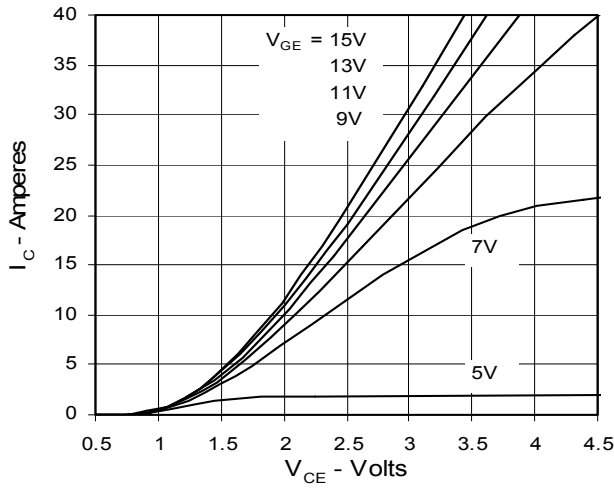
**Fig. 1. Output Characteristics  
@ 25 Deg. C**



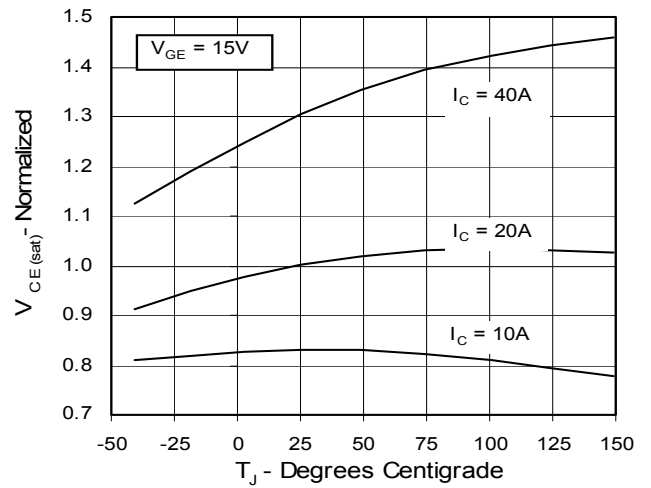
**Fig. 2. Extended Output Characteristics  
@ 25 deg. C**



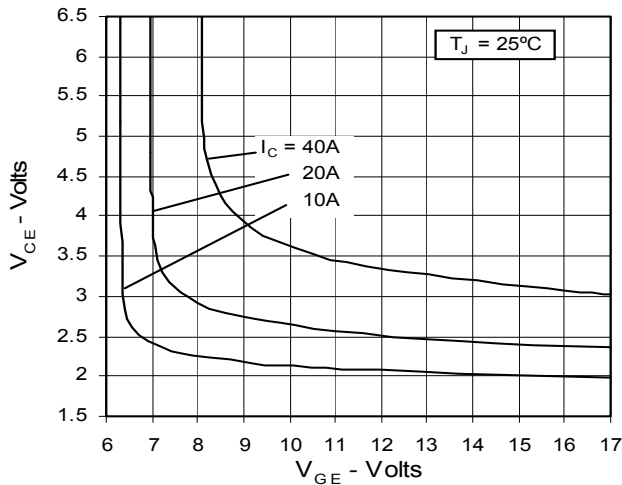
**Fig. 3. Output Characteristics  
@ 125 Deg. C**



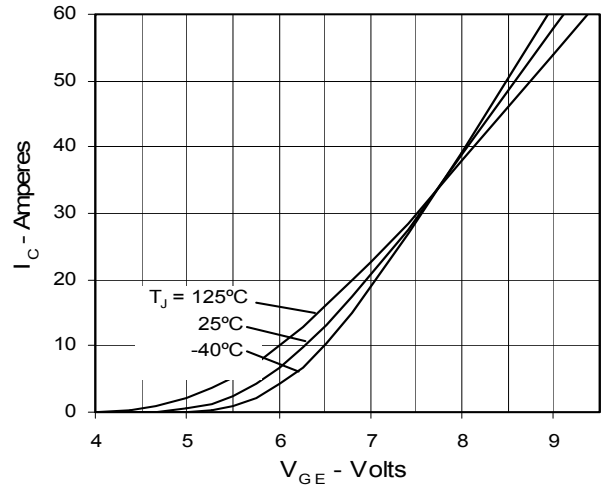
**Fig. 4. Dependence of  $V_{CE(sat)}$  on  
Temperature**



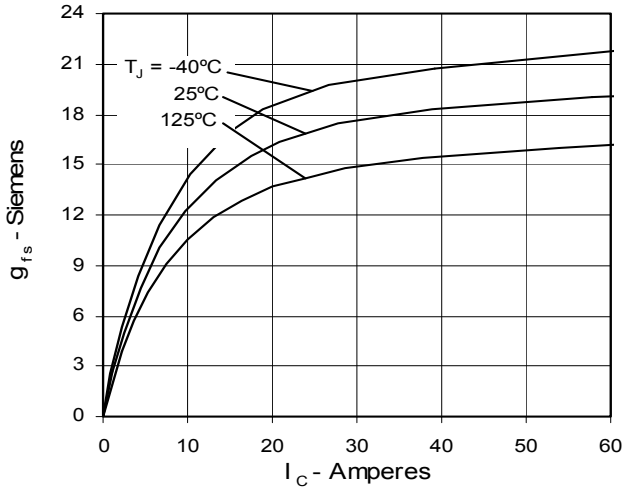
**Fig. 5. Collector-to-Emitter Voltage  
vs. Gate-to-Emitter voltage**



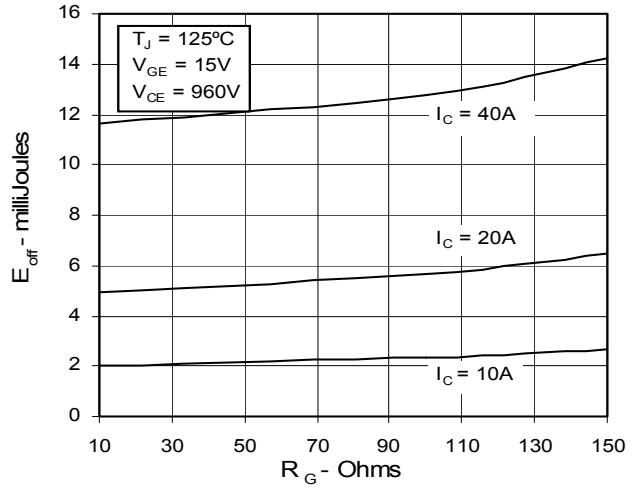
**Fig. 6. Input Admittance**



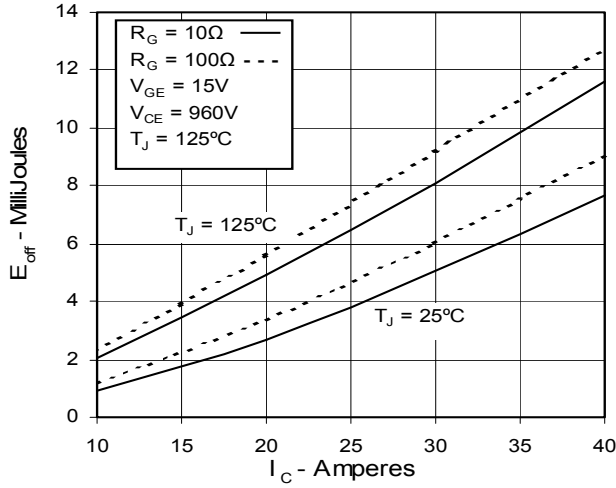
**Fig. 7. Transconductance**



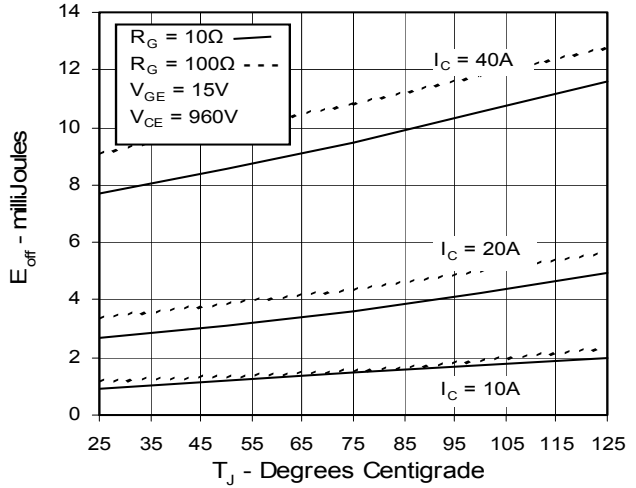
**Fig. 8. Dependence of Turn-off Energy Loss on  $R_G$**



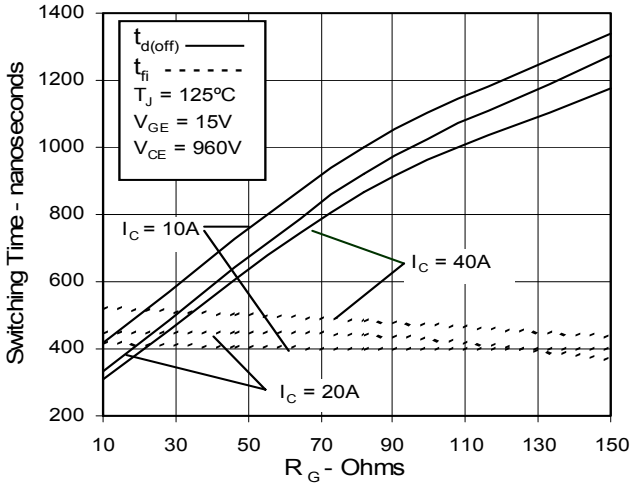
**Fig. 9. Dependence of Turn-Off Energy Loss on  $I_C$**



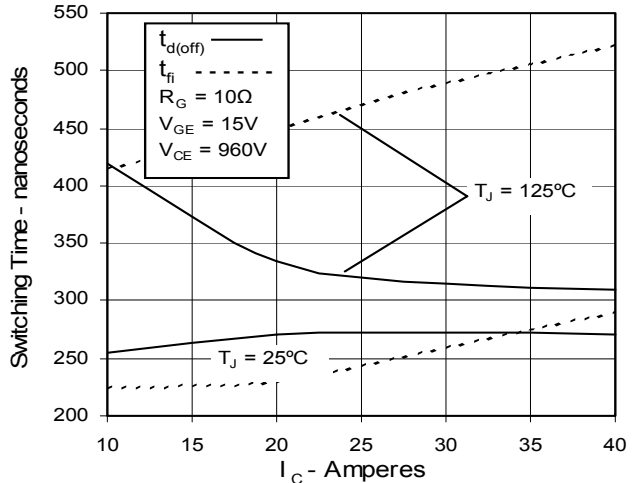
**Fig. 10. Dependence of Turn-off Energy Loss on Temperature**



**Fig. 11. Dependence of Turn-off Switching Time on  $R_G$**



**Fig. 12. Dependence of Turn-off Switching Time on  $I_C$**

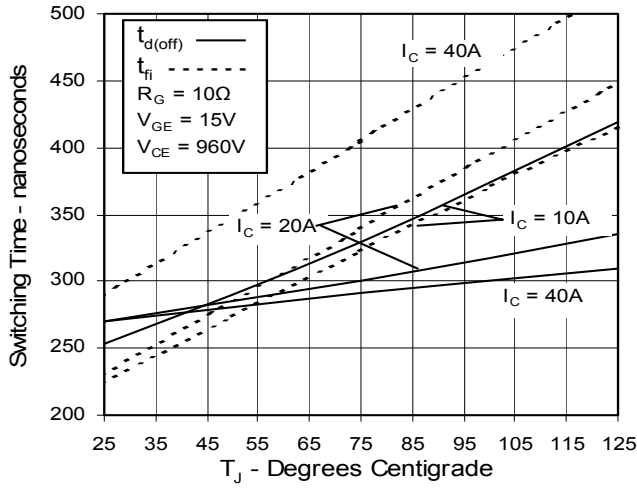


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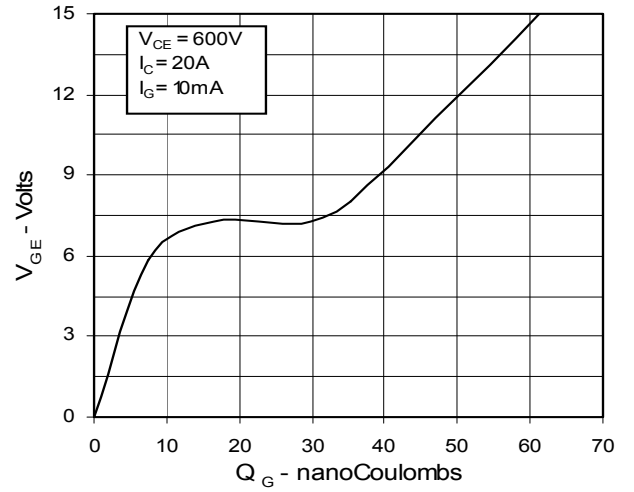
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4,850,072 4,931,844 5,034,796 5,063,307 5,237,481 5,381,025 6,404,065B1 6,162,665 6,534,343

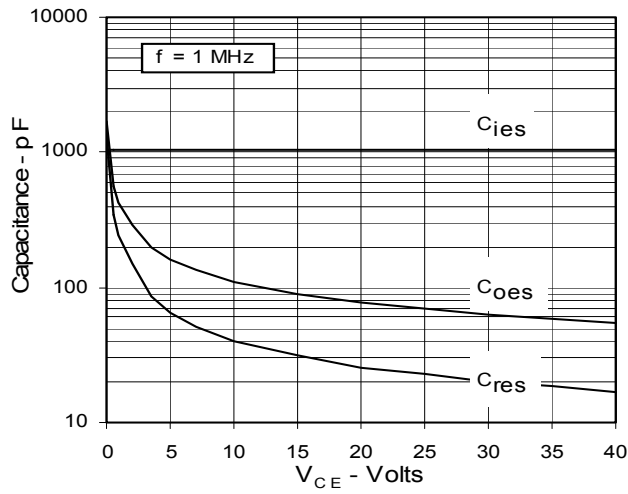
**Fig. 13. Dependence of Turn-off Switching Time on Temperature**



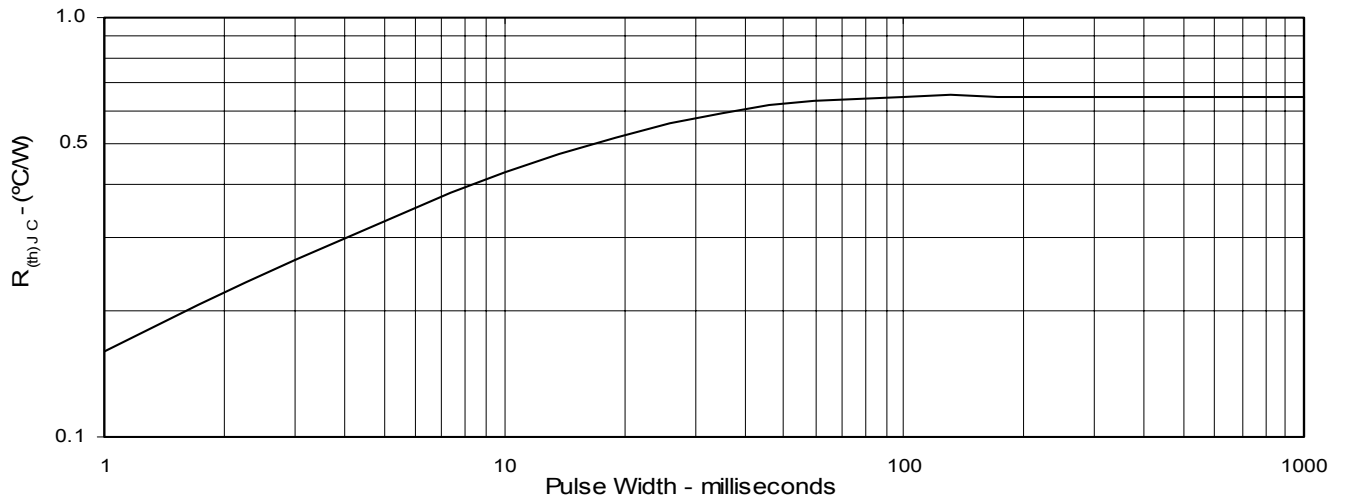
**Fig. 14. Gate Charge**



**Fig. 15. Capacitance**



**Fig. 16. Maximum Transient Thermal Resistance**



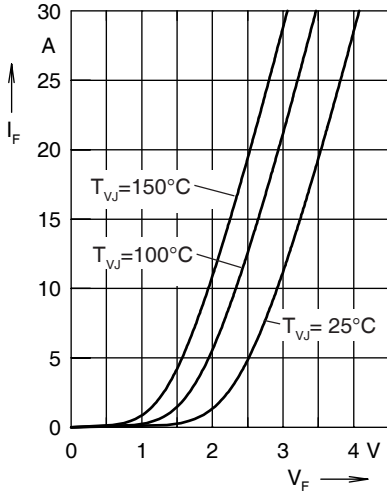


Fig. 17 Forward current  $I_F$  versus  $V_F$

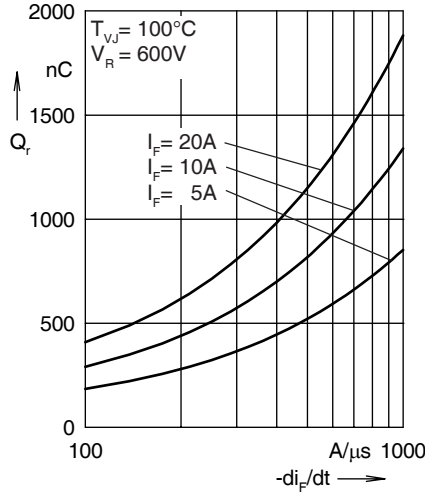


Fig. 18 Reverse recovery charge  $Q_r$  versus  $-di_F/dt$

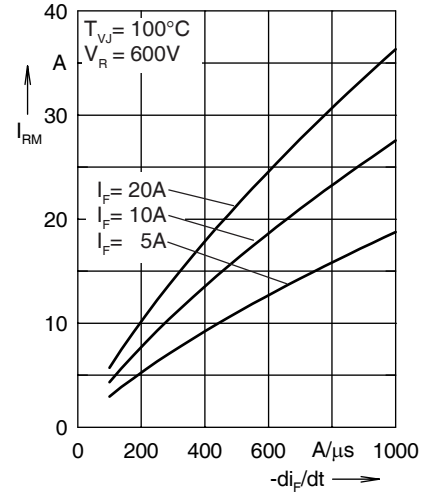


Fig. 19 Peak reverse current  $I_{RM}$  versus  $-di_F/dt$

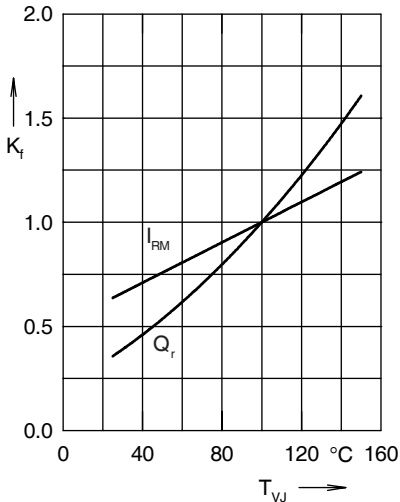


Fig. 20 Dynamic parameters  $Q_r$ ,  $I_{RM}$  versus  $T_{VJ}$

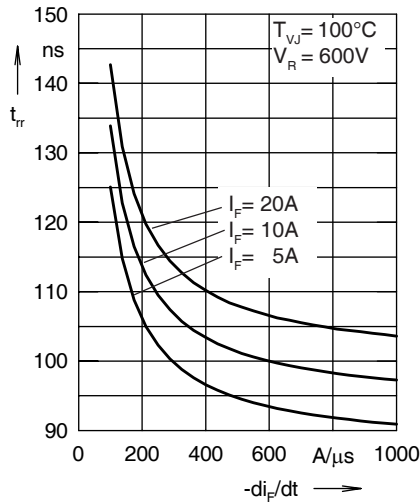


Fig. 21 Recovery time  $t_{rr}$  versus  $-di_F/dt$

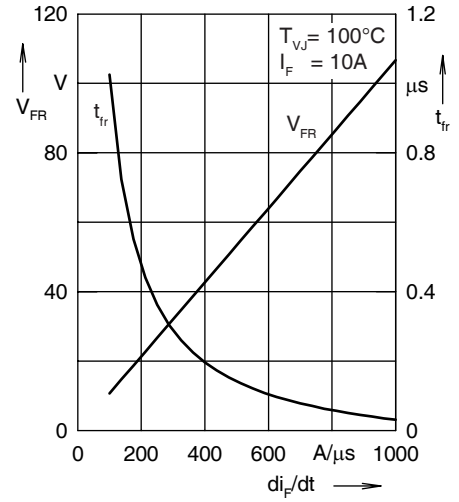


Fig. 22 Peak forward voltage  $V_{FR}$  and  $t_{rr}$  versus  $di_F/dt$

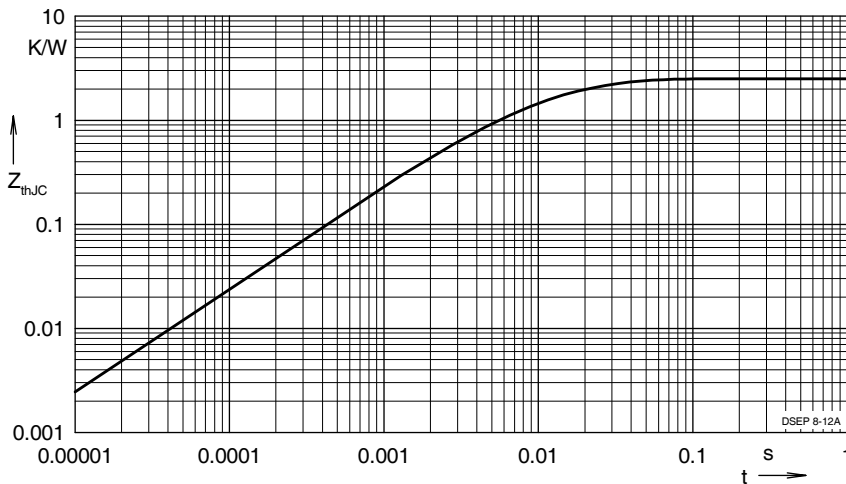


Fig. 23 Transient thermal resistance junction to case

Constants for  $Z_{thJC}$  calculation:

| i | $R_{thi}$ (K/W) | $t_i$ (s) |
|---|-----------------|-----------|
| 1 | 1.449           | 0.0052    |
| 2 | 0.558           | 0.0003    |
| 3 | 0.493           | 0.017     |

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IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents:

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4,850,072 4,931,844 5,034,796 5,063,307 5,237,481 5,381,025 6,404,065B1 6,162,665 6,534,343